

Sheet 1 of 1

FORM PTO-144 (REV. 7-80) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. H-1132 SERIAL NO. 10/796,175

LIST OF DOCUMENTS CITED BY APPLICANT
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H. ARAKAWA et alFILING DATE
March 10, 2004GROUP
2165

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
<i>W</i>	AA	2005/ 0102554	05/12/05	Zohar	-	-	
	AB	2004/ 0268177	12/30/04	Ji	-	-	
	AC	2004/ 0260972	12/23/04	Ji	-	-	
	AD	2004/ 0250031	12/09/04	Ji	-	-	
	AE	2004/ 0250030	12/09/04	Ji	-	-	
	AF	2005/ 0033828	02/10/05	Watanabe	-	-	
	AG	2003/ 0078903	04/24/03	Kimura	-	-	
	AH	5,603,003	02/11/97	Akizawa	-	-	
	AI	5,404,548	04/04/95	Nishioka	-	-	
	AJ	2005/ 0120092	06/02/05	Nakano	-	-	
<i>W</i>	AK	2002/ 0078296	06/20/02	Nakamura	-	-	

FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>W</i>	AL	06-149485	05/27/94	JP (with English Abstract)	-	-	<input type="checkbox"/>	<input type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	
	AS	
	AT	

EXAMINER

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Sheet 1 of 1FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
H-1132SERIAL NO.
10/796,175**LIST OF DOCUMENTS CITED BY APPLICANT**
(Use several sheets if necessary)APPLICANT
H. ARAKAMA et al.FILING DATE
March 10, 2004GROUP
2161**U.S. PATENT DOCUMENTS**

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					

FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	SDRF/Asynchronous: A Technical Description, EMC White Paper, EMC Corporation, Feb. 2004, pages 1-13.
	AS	
	AT	

EXAMINER

DATE CONSIDERED

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